# Studies on the Properties of CdS Films Deposited from pH-controlled Growth Solutions

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In this work we have studied the properties of CdS films obtained by the chemical bath deposition technique. We studied the influence of pH control of the reaction solution on the structural and optical properties of chemically deposited CdS films. For this, we deposited two sets of CdS films on glass substrates using two different reaction solutions. The main difference between the solutions was that one included the use of a pH-10 NH<sub>4</sub>OH/NH<sub>4</sub>Cl controller solution or buffer, which produces a more uniform pH of the reaction solution during the film-growth process. Using each reaction solution, five CdS films were deposited at 80 °C, varying the deposition time from 15 to 120 minutes. The structural and optical properties of both sets of films were determined by X-ray diffraction and by absorption, transmission and reflection spectroscopy. The differences in the properties of the films were analyzed in terms of pH control.

**Keywords:** *cadmium sulfide, structural properties, optical properties, chemical deposition PACS:* 68.55.-*a*, 68.55.*Jk*, 81.05.*Dz*, 81.10.*Dn*, 81.16.*Be*.

### 1. Introduction

In recent decades many research groups have been interested in the study of CdS films<sup>1-12</sup>, promoted by the excellent properties that make this material one of the most promising materials in the field of photovoltaic conversion energy. Among the most important applications of CdS films are solar cells. Several recent papers report high-efficiency solar cells based on CdS/CdTe, CdS/CuInSe<sub>2</sub> and CdS/Cu(In,Ga)Se<sub>2</sub><sup>[13-25]</sup> heterostructures, employing CdS films as the window layers. In the last few years interest has also developed to use CdS films as semiconductor active layers in thin-film transistors (TFT)<sup>26-30</sup>. The studies on CdS films with better structural, electrical and optical properties, in order to increase their performance in optoelectronic devices, such as solar cells and TFTs.

One of the most simple and widely used growth techniques to prepare CdS films is chemical bath deposition  $(CBD)^{21,22}$ , in which a substrate is immersed in an alkaline aqueous solution containing Cd<sup>2+</sup> and S<sup>2-</sup> ions resulting from chemical reactions in the solution. In order to obtain gradual deposition of the CdS film on the substrate several conditions must be met. One of the key factors in the CBD

process of CdS films is the complexing agent of the Cd<sup>2+</sup> ions. The employment of an appropriate complexing agent in the reaction solution guarantees the slow release of the Cd2+ ions, promoting gradual reaction with the S2- ions and avoiding fast precipitation of CdS. Ammonia is the typical complexing agent used in CBD of CdS films. The deposition parameters that control the properties of the films in this technique are the temperature and pH of the aqueous solution and the relative concentration of the reactives providing the Cd2+ and S2- ions. Two growth kinetics mechanisms have been identified for the chemical deposition of CdS films<sup>22,31</sup>. The first one consists in an ion by ion gradual condensation of Cd2+ and S2- ions on the substrate, which produces thin, stoichiometric, well-adhered and specularly reflecting CdS films with hexagonal (wurtzite) structure. The second growth kinetics mechanism consists in adsorption on the substrate of CdS clusters formed in the solution, yielding the deposition of thick, rough and diffusely reflecting CdS films with cubic (sphalerite) structure. The occurrence of one or the other growth process depends on the initial conditions of the reaction solution and on its time evolution. For example we have observed the ion by ion mechanism during the early growth stages and a switch to the cluster by cluster one after some time into the CdS deposition process<sup>32</sup>.

Chemically deposited CdS films are among the best window layers for polycrystalline thin-film solar cells based on CdTe and Cu(In,Ga)Se<sub>2</sub> (CIGS) absorber layers. Some of the recently performed research on CdS obtained by the CBD technique has been on the influence of the growth parameters on solar cell efficiency14. However, there are still important issues about the chemical deposition of CdS films that are worth studying. The pH of the reaction solution is a very important factor for the films deposition by the DBQ technique and several works report on the effect of this parameter on the properties of CdS films<sup>33,34</sup>. In these papers the pH of the reaction solution for different CBD processes is optimized to attain the best properties of the CdS layers. Instead, in this work we have focused on the influence of the control of pH parameter of the reaction solution on the properties of chemically deposited CdS films. For this, we used the CBD technique to deposit CdS films using two types of solutions. The differences between the reaction solutions was that in one of them ammonia was substituted completely by sodium citrate as the complexing agent and KOH and pH 10 buffer were included in the precursor solution to attain the pH required value and to control the pH of the solution during the whole deposition process. Both kinds of deposited CdS films were studied to determine the influence of the pH control in the reaction solution on the properties of the films.

#### 2. Experimental Details

The CBD technique was used to deposit CdS films using two types of solution. The solutions were similar, containing cadmium chloride as the source of Cd2+ ions and thiourea as the source of S2- ions. In one solution ammonia and sodium citrate were used as the complexing agents of Cd2+ ions (identified as solution "A"), whereas only sodium citrate was used in the second solution (identified as solution "B"). For solution B, KOH and a pH-10 buffer were included in the precursor solution to attain the required pH and to control the pH of the solution during the entire deposition process. The deposition of A films was done in a reactive solution prepared by the sequential addition of 25 mL of 0.1 M CdCl<sub>2</sub>, 20 mL of 1 M C<sub>6</sub>H<sub>5</sub>O<sub>7</sub>Na<sub>3</sub> (sodium citrate), 1mL of 1M NH<sub>4</sub>OH and 10 mL of 1 M CS(NH<sub>2</sub>)<sup>[35]</sup>. Deionized water was added to the solution to produce a total volume of 100 mL. The B films were grown in a reactive solution prepared by the sequential addition of 25 mL of 0.1 M CdCl<sub>2</sub>, 20 mL of 1M C<sub>6</sub>H<sub>5</sub>O<sub>7</sub>Na<sub>2</sub>, 5 mL of 1M KOH, 15 mL of 1M of pH-10 NH<sub>4</sub>OH/NH<sub>4</sub>Cl buffer and 10 mL of 1 M CS(NH<sub>2</sub>)<sup>[36]</sup>. Deionized water was also added to this solution to produce a total volume of 100 mL. The two types of films were deposited on glass slide substrates at a solution temperature of 80 °C. The solutions were not stirred during the deposition processes. In each case five substrates were placed in the reaction beaker, and they were subsequently removed from the solution after 15, 30, 60, 90 and 120 minutes, respectively. The initial pH of the A solution was 11.6 and it decreased to 10 at the end of the deposition process. Meanwhile, the pH of B solution was 10 during the whole deposition process because of the influence of the buffer solution. The resulting CdS films in both cases had a green-yellowish color and were homogeneous, specularly

reflecting with a very good adherence to the substrate. The crystalline structure of the films was determined from X-ray diffraction (XRD) patterns measured on a Rigaku D/max-2100 diffractometer using Cu K $\alpha$  radiation. The absorption spectra of the films were obtained in a Perkin-Elmer Lambda 2 Spectrophotometer. The thickness and refraction index of the films were deduced from reflection and transmission spectroscopy measurements made in a Film Tek<sup>TM</sup> 3000 spectrometer.

#### 3. Results and Discussion

Figure 1 shows the XRD patterns for the A CdS films. The patterns show the increasing presence with deposition time of polycrystalline structure in these films, displaying diffraction lines at about 25, 26.5, 28.2 and 44°, situated on a broad reflection produced by the amorphous substrate. The four peaks are produced by the (100), (002), (101) and (110) crystalline planes, respectively, of the hexagonal CdS structure. The increase in intensity of the crystalline peaks with deposition time is due to the increase of the film thickness. The relative intensity of the (002) reflection indicates a preferred orientation along the [002] direction. These results are in agreement with structural data reported in the literature for chemically deposited CdS films prepared with a similar reaction solution<sup>35</sup>. Figure 2 shows the XRD patterns for the B CdS films. These patterns also display the (100), (002) and (110) diffraction lines of the hexagonal CdS structure. However, the (101) diffraction line does not appear or is very weak. The intensity of the peaks (i.e., film thickness) also increases with deposition time. The ratio of the (002) peak intensity to the (100) and (110) peak intensity is much larger than for the A films, indicating a stronger [002] preferred orientation. It is known that the surface mobility of adsorbed species at the substrate surface has a strong influence on the crystalline structure during the growth process<sup>37</sup>. For example, an amorphous layer,

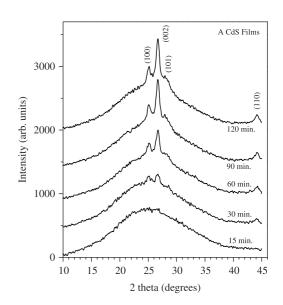


Figure 1. X-ray diffraction patterns of the A CdS films deposited for 15, 30, 60, 90 and 120 minutes.

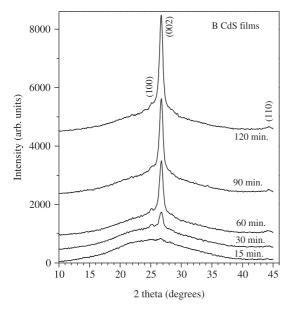
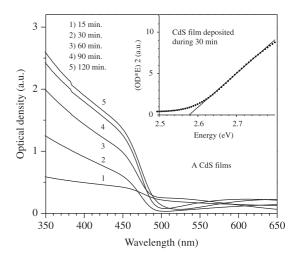


Figure 2. X-ray diffraction patterns of the B CdS films deposited for 15, 30, 60, 90 and 120 minutes.

highly disordered, is obtained when the mobility of the species arriving to the substrate is very low. On the other hand, crystalline layers with high crystalline orientation can be obtained when the mobility of the species is high. The initial pH in solution A is 11.6, which means a higher concentration of OH- ions and thus faster generation of S2ions by the thermal hydrolysis of thiourea. The nucleation of a precipitate in the reaction solution begins in some local regions with inhomogeneities where the ionic product is larger than the solubility product<sup>22</sup>. The subsequent growth of these precipitates by the addition of more ions from the solution results in the formation of stable clusters in the solution which can be deposited on the film. The lower mobility of the cluster adsorbed to the substrate surface could be the origin of the lower preferred orientation observed in the A films relative to the B films. In fact, we have shown in a previous paper that the A films indeed do grow by the cluster by cluster mechanism<sup>31</sup>. On the other hand, the lower initial pH in solution B and the control of the pH during deposition avoids or diminishes the creation of inhomogeneous regions in the solution, promoting the direct reaction of elementary species at the substrate surface (e.g., promoting ion by ion deposition of the films). The lighter ions adsorbed to the substrate have higher mobility and thus provide the origin of the higher preferred orientation observed in the B films.

Figures 3 and 4 show the absorption spectra obtained from the A and B films, respectively. In both figures the spectra show an absorption edge at about 490 nm due to the fundamental absorption of CdS. The optical density at lower wavelengths (< 490 nm) increases with the deposition time of the films because of the increase in film thickness. From these spectra the energy band gap, Eg, of the films was obtained. To accomplish this,  $(OD^*E)^2$  was plotted versus E and the model for direct allowed transitions between



**Figure 3.** Optical absorption spectra of the A CdS films. The inset is the  $(OD*E)^2$  versus E graph, with the linear fit (solid line) to the experimental data (dotted line), for the film deposited for 60 minutes.

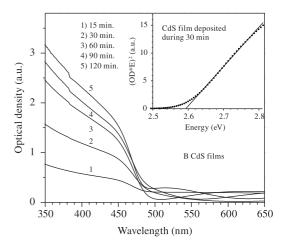
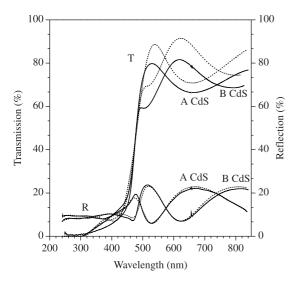


Figure 4. Optical absorption spectra of the B CdS films. . The inset is the  $(OD*E)^2$  versus E graph, with the linear fit (solid line) to the experimental data (dotted line), for the film deposited for 60 minutes.

parabolic energy bands was applied<sup>38</sup>. Here, *OD* is the optical density, and *E* is the photon energy. The insets in Figures 3 and 4 show the  $(OD^*E)^2$  versus *E* graphs, with the linear fit (solid line) to the experimental data (dotted line), for the films deposited for 60 minutes. By averaging the values of *Eg* obtained for each type of film, we found that both types of CdS film have a similar average of ~2.58 eV. This value of *Eg* is larger than the value reported for bulk CdS and for that of other chemically deposited CdS films prepared using different reaction solutions<sup>7,9,10</sup>.

The growth kinetics for the deposition processes was determined from transmission and reflection spectroscopy. The transmission and reflection spectra for the A and B films deposited for 120 minutes are shown in Figure 5. They have the same absorption edge at ~500 nm. The transmission of the films at larger wavelengths than the absorption



**Figure 5.** Experimental (solid lines) and theoretical (dotted lines) transmission and reflection spectra of the A and B CdS films deposited for 120 minutes.

edge is between 70 and 90% and drops to 10 % at lower wavelengths. The reflectance of the films is between 10 and 20% over the entire wavelength range. In these spectra the absorption edge of CdS is also manifested at about 500 nm. The oscillations of both transmission and reflection of the films in the semi-transparent region are due to interference with the light reflected at the substrate-layer interface. The transmission and reflection spectra of the CdS films were fitted by the Tauc-Lorentz model using a two-layer system representing the glass substrate and the CdS layer<sup>39,40</sup>. In this model, the dispersion relation is given by the product of the Tauc joint density of states above the band edge for amorphous materials and the imaginary part of the Lorentz harmonic oscillator dielectric function. Therefore, the expression for the imaginary part of the dielectric function as a function of photon energy,  $\varepsilon_2(E)$ , for  $E > E_a$ , is given by

$$\varepsilon_2(E) = \sum_{j=1}^2 \frac{A_j^2(E_0)_j v(E - E_g)^2}{[E^2 - (E_0)_j^2]^2 + v^2 E^2} \cdot \frac{1}{E}$$
(1)

where *j* is the number of oscillators (two were considered in our case), *A* is the amplitude,  $E_0$  the central energy and v the damping coefficient for each oscillator. For  $E < E_g$ ,  $\varepsilon_2(E)=0$ . The real part of the dielectric function,  $\varepsilon_1(E)$ , is obtained by means of Kramer-Kronig integration

$$\varepsilon_1(E) = \varepsilon_{\infty} + \frac{2}{\pi} P \int_{E_g}^{\infty} \frac{\xi \varepsilon_2(\xi)}{\xi^2 - E^2} d\xi$$
<sup>(2)</sup>

where  $\varepsilon_{\infty}$  is the high frequency lattice dielectric constant,  $\xi$  is an integration energy variable and *P* denotes the principal value of the integral. The optical measurement system used for the *T* and *R* measurements includes the software (Film Wizard<sup>®</sup>) to perform the fits of this model to experimental optical spectra. The best fits for each spectrum are plotted as discontinuous lines in Figure 5. As observed in the figure, the

reflectance spectra fit quite well to the model over the entire wavelength range. The transmission spectra fit very well below the absorption edge, but in the semi-transparent region there is a distinct discrepancy; the experimental transmission is lower than the simulated data. This discrepancy could be due to the loss of light due to scattering by the films.

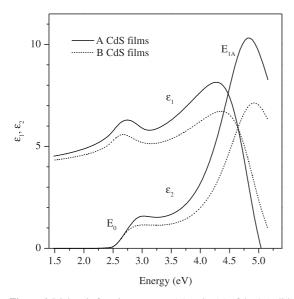
From the fits of the spectra we obtained the complex dielectric function,  $\varepsilon_1 + i\varepsilon_2$ , and thickness of both types of films. The real,  $\varepsilon_1$ , and complex,  $\varepsilon_2$ , components of the complex dielectric function of the CdS films as a function of photon energy are shown in Figure 6. The spectra plotted with continuous lines correspond to the A films, and the spectra in dotted lines correspond to the B films. The shapes of the  $\varepsilon_1$  and  $\varepsilon_2$  spectra, respectively, are very similar for the two types of film, the spectra of A films having higher intensity, which in the case of the  $\varepsilon_1$  spectrum is related to the refraction index and is evidence of more compact films<sup>40</sup>. Two transitions can be observed in these spectra indicated by  $E_0$  and  $E_{1A}$  in the  $\varepsilon_2$  spectra. The first transition at about 2.5 eV is due to the absorption of light at the fundamental gap,  $E_0$ , of CdS. The energy,  $E_{1A}$ , at about 4.8 eV represents the energy of the transitions along the  $\Gamma \rightarrow A$  direction of the Brillouin zone of the CdS wurtzite lattice<sup>41</sup>. The shape of the spectra and the energy of the transitions at the critical points measured in the CdS films agree with those measured in hexagonal CdS crystals by means of spectroscopic ellipsometry<sup>41</sup>.

Figure 7 shows the thickness of the films as a function of deposition time, obtained from the fittings of the transmission/reflection versus wavelength curves for all samples (as shown for the 120 minutes. samples in Figure 5). Initially a fast and almost linear increase in thickness is observed for both the A and B reactions. The thickness is about 40 nm for both types of film after 15 minutes of deposition, and it increases up to 240 and 290 nm for A and B films, respectively, after 120 minutes. of deposition. From these results it can be concluded that the deposition process for the B films produces a higher deposition rate, higher final film thickness and also higher effective termination time (i.e., the time necessary to attain the final film thickness). The differences could be related to the difference in the initial value of the pH of the solutions and to the better pH control of the B solution during growth. The pH control is achieved by the addition of NH<sub>4</sub>OH/NH<sub>4</sub>Cl as a buffer, which controls the amount of free OH- ions in the reaction solution. Buffers are usually mixtures of weak acids or bases and their salts. The buffering action of this solution can be understood by considering the following equilibrium equations:

$$NH_3 + H_2O \rightleftharpoons NH_4^+ + OH^-$$
(3)

$$\mathrm{NH}_3 + \mathrm{H}^+ \rightleftharpoons \mathrm{NH}_4^+ \tag{4}$$

If extra OH<sup>-</sup> ions are added to the solution, the equilibrium is shifted to the left in Equation 3; it tends to remove OH<sup>-</sup> ions. On the other hand, if H<sup>+</sup> ions are added, they are consumed to convert ammonia to  $NH_4^+$  ions (Equation 4). The OH<sup>-</sup> ions are necessary for the nucleation (Equation 5) and CdS synthesis (Equation 6) stages of the CBD process,



**Figure 6.** Dielectric function spectra  $\varepsilon_1(E)$  and  $\varepsilon_2(E)$  of the A (solid lines) and B (dotted lines) CdS films deposited for 120 minutes.

reacting with  $Cd^{+2}$  ions to form  $Cd(OH)_2$  nuclei and then CdS by reaction with S<sup>-2</sup> ions from the thermal hydrolysis process of thiourea (Equations 7a and 7b), according to the following chemical reactions:

$$\operatorname{Cd}^{+2} + 2\operatorname{OH}^{-} \rightleftharpoons \operatorname{Cd}(\operatorname{OH})_{2(s)}$$
 (5)

$$Cd^{+2} + S^{-2} \rightleftharpoons CdS_{(s)} \tag{6}$$

$$SC(NH_2)_2 + 2OH^- \rightleftharpoons S^{-2} + H_2O + CN_2H_2$$
 (7a)

$$HS^- + OH^- \rightarrow S^{-2} + H_2O \tag{7b}$$

It has been found that deposition rate of CdS films that grow by the ion by ion process increases with the pH of the initial reaction solution<sup>22</sup>. This explanation does not apply to this study. Rather, the higher deposition rate of the B films is a consequence of the lower initial pH and the pH control of the reaction solution. As stated above, the higher initial pH and the lack of control of the pH in the A solution produces

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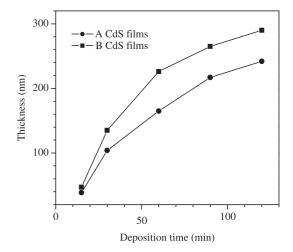


Figure 7. Thickness of the A and B CdS films as a function of deposition time.

a faster formation of stable clusters with the consequent homogeneous CdS precipitation in the solution. Thus, there will be less available elementary species to be incorporated in the film, yielding a decrease in the deposition rate and the final film thickness.

#### 4. Conclusions

By comparing the properties of the CdS films we can conclude that the lower initial pH and the control of the pH by adding a pH-10 buffer to the reaction solution to grow the B CdS films produces hexagonal CdS films with a higher degree of preferred orientation along the [002] crystalline direction. The use of the buffer also increases the growth kinetics, resulting in thicker films. However, the optical properties, such as energy band gaps at the critical points of the electronic band structure of CdS, are not affected by the use of the buffer.

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